Application/Control No. Applicant(s)/Patent Under Reexamination CHO, JOUNG-HWAN Examiner Kiran B. Patel Application/Control No. Applicant(s)/Patent Under Reexamination CHO, JOUNG-HWAN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,120,069	09-2000	Taranto, Ron	292/DIG.41
	В	US-5,782,510	07-1998	Gass, Paul E.	292/DIG.41
	С	US-2004/0168487	09-2004	Sawatani et al.	070/145
	D	US-2004/0017088	01-2004	Sawatani et al.	292/178
	Е	US-6,669,243	12-2003	Katoh et al.	296/37.8
	F	US-5,535,608	07-1996	Brin, Constantin	292/DIG.43
	G	US-6,164,711	12-2000	Neal et al.	296/37.12
	Н	US-5,931,031	08-1999	Bouan, Bruno	70/57.1
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002-274273	09-2002	JAPAN		
	0	JP5-338500	12-1993	JAPAN		
	Р	DE 33 36 952	06-1984	GERMANY		
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	
	>	
	w	·
	x	

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